



Figure 1. Top View of AT6538

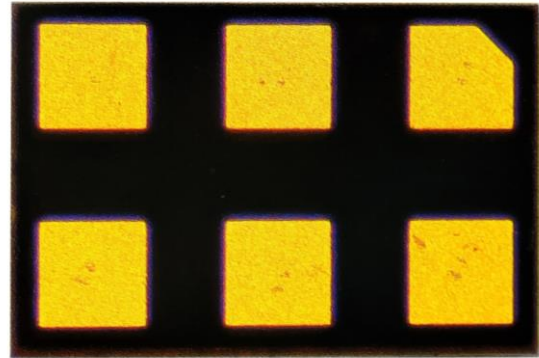


Figure 2. Bottom View of AT6538

FEATURES

- The lowest frequency microphone in the world
- Stable sensitivity over power supply range of 1.6V~3.6V
- SNR of 63dB(A)
- Sensitivity of -26dB FS
- Multi Chip Module (MCM) Package
- 2.75mm×1.85mm×1.25mm surface-mount package

APPLICATIONS

- Mobile Telephones
- PDAs
- Digital Video Cameras
- Portable Media Devices with Audio Input

DESCRIPTION

The AT6538 is a high quality, high performance, low power digital output top-ported omni-directional MEMS microphone. AT6538 consists of a MEMS microphone element and an analog-to-digital converter. AT6538 has a high SNR and flat wideband frequency response with $\pm 2\text{dB}$ in 12KHz. Sensitivity is a single tone distribution in a narrow window with under $\pm 1\text{dB}$, resulting in natural sound with high intelligibility. Due to built-in filter, AT6538 shows high immunity to EMI. The AT6538 is available in a thin 2.75mm × 1.85mm × 1.25mm surface-mount package. It is reflowing solder compatible with no sensitivity degradation. The AT6538 is Halogen and Lead free.

PIN CONFIGURATIONS

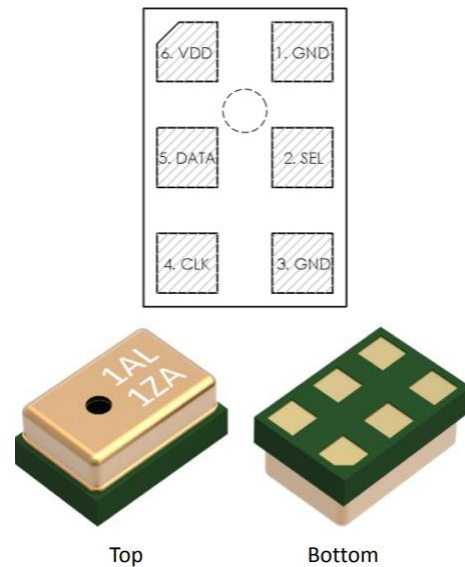


Figure 3. Pin Configurations

PIN DESCRIPTION

Table 1.

Pin	Symbol	Description
1	GND	Ground
2	SEL	Select
3	GND	Ground
4	CLK	Clock
5	DATA	Output
6	VDD	Power supply



ABSOLUTE MAXIMUM RATINGS

Table 2.

Parameter	Rating
CLOCK to Ground	-0.3V to +6.0V
SELECT, V _{DD} , DATA to Ground	-0.3V to +6.0V
Input Current	±5mA
Operating Temperature	-40°C to +125°C
Storage Temperature	-40°C to +125°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to

the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.



ESD CAUTION

This integrated circuit can be damaged by ESD. It is recommended that all integrated circuits be handled with proper precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure.

ELECTRICAL CHARACTERISTICS

(T_A = +23°C, V_{DD} = +1.8V, f_{clock} = 3.072MHz, R.H. = 60%~70%, no load, V_{DD} Decoupling cap=1.0uF unless otherwise noted.)

Table 3.

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Power Supply Voltage ¹	V _{DD}		1.6		3.6	V
Clock Frequency	f _{clock}		1.0		4.8	MHz
Current Consumption t ^{1,6}	I _{DD}			600	700	µA
Standby Current (Sleep Mode) ^{5, 6}	I _{STANDBY}	f _{clock} < 250kHz		80		µA
Directivity			Omni-directional			
Sensitivity ¹	S	94dB SPL @1kHz	-27	-26	-25	dB FS
Signal to Noise Ratio	SNR	94dB SPL @1kHz, A-weighted		63		dB(A)
Total Harmonic Distortion	THD	120dB SPL 1 kHz			10	%
Acoustic Over load Point	AOP	10% THD @1kHz		120		dB SPL
Power Supply Rejection	PSR	217Hz, 100mV _{p-p} , square wave on V _{DD}	V _{DD} = 1.8V	-65		dB FS
			V _{DD} = 3.3V	-71		
Polarity		Increasing sound pressure	Increasing density of 1's			
Fall-Asleep Time ^{2, 3}		V _{DD} = On, f _{clock} < 1KHz			10	ms
Wake-Up Time ^{2, 4}		V _{DD} = On, f _{clock} ≥ 1KHz			10	ms



Parameter	Symbol	Test Conditions		Min.	Typ.	Max.	Unit	
Short Circuit Output Current	I_{SC}	Grounded output pin			1	10	mA	
Output Load	C_{LOAD}					100	pF	
Data Format				1/2 cycle PDM				
Clock Duty Cycle				40		60	%	
Clock Rise Time	t_{cr}					10	ns	
Clock Fall Time	t_{ct}					10	ns	
Logic Input/Output Low	V_{IOL}			$I_{out} = 1mA$		-0.3		$0.35 \times V_{DD}$
Logic Input/Output High	V_{IOH}	$I_{out} = 1mA$		$0.65 \times V_{DD}$		$V_{DD} + 0.3$	V	
Delay Time for Valid Data	t_{dv}	CLK = 3.072MHz, Oscilloscope: APx525 (probe $C_{in} = 24pF$)	Data Transition High	1.8V	30		180	ns
				3.3V	24		119	
			Data Transition Low	1.8V	30		180	
				3.3V	22		118	
Delay Time for High Z	t_{dz}	CLK = 3.072MHz, Oscilloscope: APx525 (probe $C_{in} = 24pF$)	Data Transition High	1.8V	1		14	ns
				3.3V	1		10	
			Data Transition Low	1.8V	1		14	
				3.3V	1		10	
Settling time	t_s			1.8V		13.5	25	ms
				3.3V				
Startup Time		Powered Down → Active Mode		1.8V		13.5	25	ms
				3.3V				



(T_A = +23°C, V_{DD} = +1.8V, f_{clock} = 768kHz, R.H. = 60%~70%, no load, V_{DD} Decoupling cap=1.0uF unless otherwise noted.)

Table 4.

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Power Supply Voltage ¹	V _{DD}		1.6		3.6	V
Clock Frequency	f _{clock}		350		800	kHz
Current Consumption t ^{1,6}	I _{DD}			250	290	μA
Standby Current (Sleep Mode) ^{5, 6}	I _{STANDBY}	f _{clock} < 250kHz		80		μA
Directivity			Omni-directional			
Sensitivity ¹	S	94dB SPL @1kHz	-27	-26	-25	dB FS
Signal to Noise Ratio	SNR	94dB SPL @1kHz, A-weighted		63		dB(A)
Total Harmonic Distortion	THD	120dB SPL 1 kHz			10	%
Acoustic Over load Point	AOP	10% THD @1kHz		120		dB SPL
Power Supply Rejection	PSR	217Hz, 100mV _{p-p} , square wave on V _{DD}	V _{DD} = 1.8V		-65	dB FS
			V _{DD} = 3.3V		-71	
Polarity		Increasing sound pressure	Increasing density of 1's			
Fall-Asleep Time ^{2, 3}		V _{DD} = On, f _{clock} < 1KHz			10	ms
Wake-Up Time ^{2, 4}		V _{DD} = On, f _{clock} ≥ 1MHz			10	ms
Short Circuit Output Current	I _{SC}	Grounded output pin		1	10	mA
Output Load	C _{LOAD}				100	pF
Data Format			1/2 cycle PDM			
Clock Duty Cycle			40		60	%
Clock Rise Time	t _{cr}				10	ns
Clock Fall Time	t _{ct}				10	ns
Logic Input/Output Low	V _{IOL}	I _{out} = 1mA	-0.3		0.35×V _{DD}	V
Logic Input/Output High	V _{IOH}	I _{out} = 1mA	0.65×V _{DD}		V _{DD} +0.3	V



Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Delay Time for Valid Data	t_{dv}	CLK = 3.072MHz, Oscilloscope: APx525 (probe C_{in} = 24pF)	Data Transition High	1.8V	30	180	ns
				3.3V	24	119	
			Data Transition Low	1.8V	30	180	
				3.3V	22	118	
Delay Time for High Z	t_{dz}	CLK = 3.072MHz, Oscilloscope: APx525 (probe C_{in} = 24pF)	Data Transition High	1.8V	1	14	ns
				3.3V	1	10	
			Data Transition Low	1.8V	1	14	
				3.3V	1	10	
Settling time	t_s			1.8V		13.5	ms
				3.3V		25	
Startup Time		Powered Down → Active Mode	1.8V		13.5	25	ms

Note 1: 100% tested.

Note 2: Valid microphone states are: Power Down Mode (mic off), Sleep Mode (low current, no output, fast start-up), and Active Mode (normal operation).

Note 3: Time from $f_{clock} < 1\text{kHz}$ to sleep current specification is met when transitioning from Active to Sleep Mode.

Note 4: Time from $f_{clock} \geq 1\text{MHz}$ to all applicable specifications when transitioning from Sleep to Active Mode.

Note 5: $\Delta I_{DD} = 0.5 \times V_{DD} \times C_{LOAD} \times f_{clock}$

Note 6: Specified max values are measured at $V_{DD} = +3.6\text{V}$.

BLOCK DIAGRAM

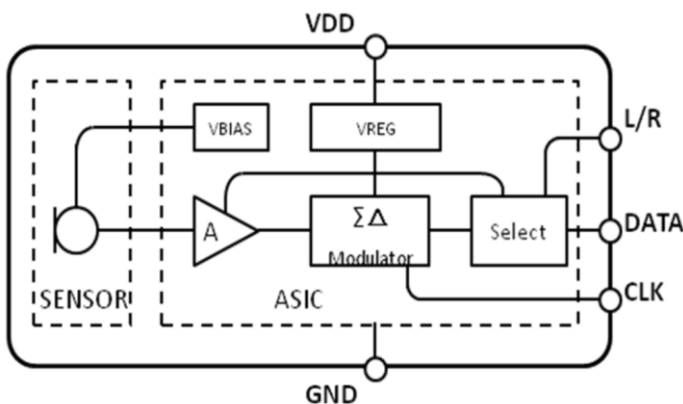


Figure 4. Block Diagram

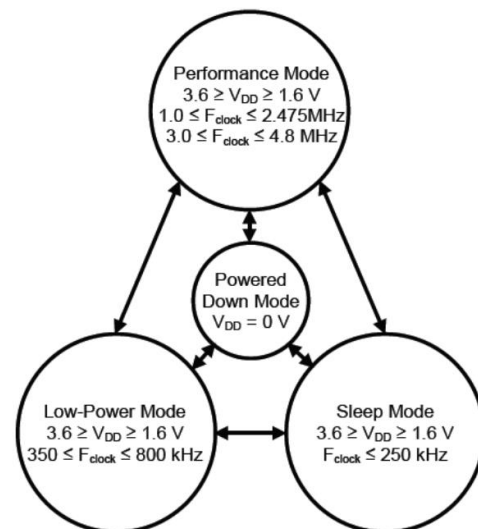


Figure 5. State Diagram



TYPICAL CIRCUIT APPLICATION

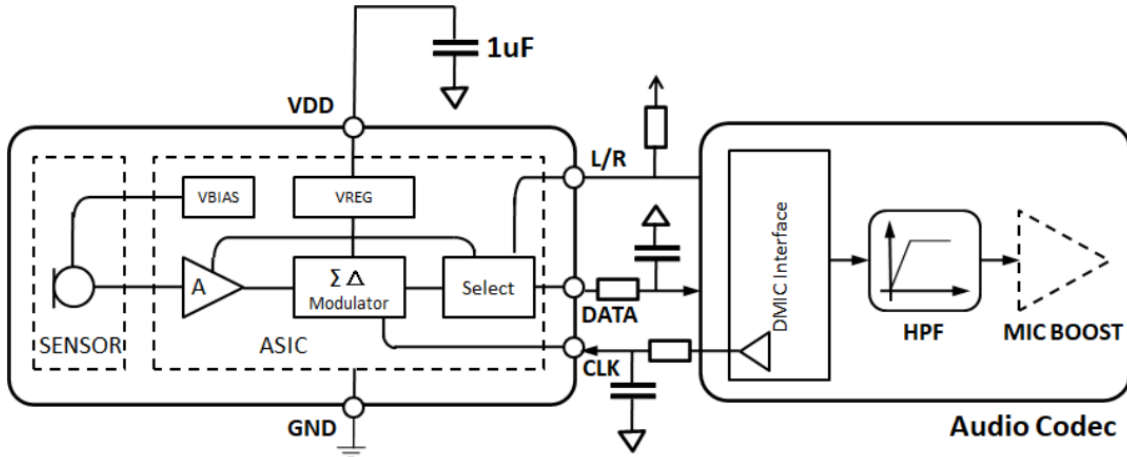
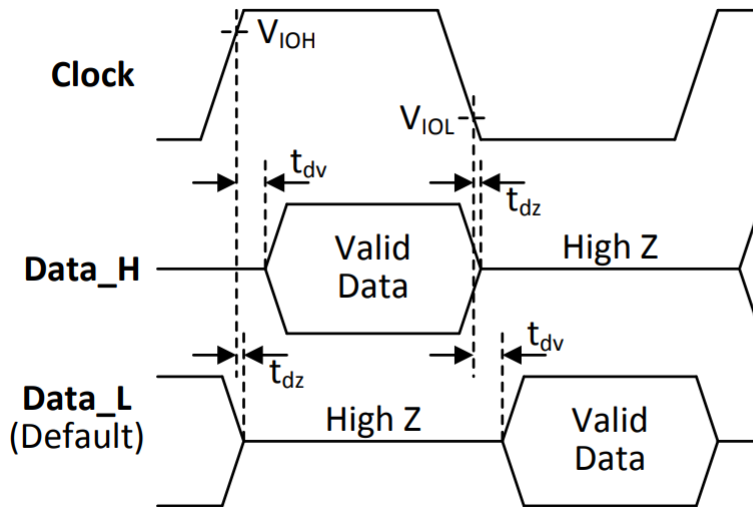
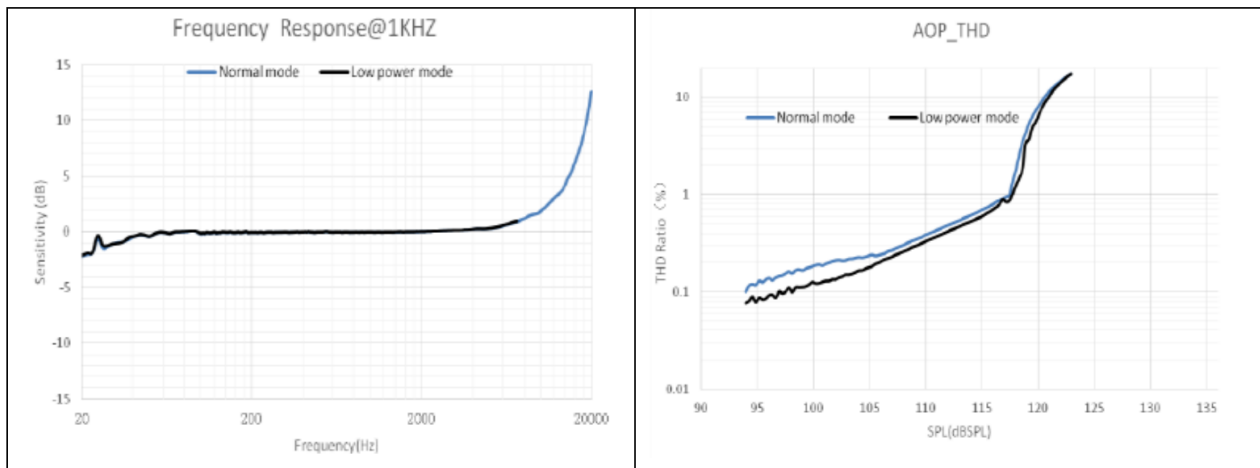


Figure 6. Typical Circuit

TIMING DIAGRAM



TYPICAL CHARACTERISTICS





TYPICAL CHARACTERISTICS

The microphone sensitivity after stress must deviate by no more than $\pm 3\text{dB}$ from the initial value.

1. Heat Test, Operational	Temperature: $125\pm 3^\circ\text{C}$ Duration: 1000 hours Voltage: Applied
2. Cold Test, Operational	Temperature: $-40\pm 3^\circ\text{C}$ Duration: 1000 hours Voltage: Applied
3. Heat Test, Non-Operational	Temperature: $125\pm 3^\circ\text{C}$ Duration: 1000 hours Voltage: Not Applied
4. Cold Test, Non-Operational	Temperature: $-40\pm 3^\circ\text{C}$ Duration: 1000 hours Voltage: Not Applied
5. Thermal Shock Test, Non-Operational	Temperature: $-40\pm 3^\circ\text{C}$ and $125\pm 3^\circ\text{C}$ Duration: 30 minutes each, during 5 minutes ramp, 256 cycles Voltage: Not applied
6. Temperature humidity storage	Temperature: $85\pm 3^\circ\text{C}$ Humidity: $85\pm 3\% \text{RH}$ Duration: 1000 hours
	Temperature: $65\pm 3^\circ\text{C}$ Humidity: $95\pm 3\% \text{RH}$ Duration: 168 hours
7. Free Fall Test 1.5m	Placed inside test fixture and dropped on concrete from height 1.5m. 4 times by each surface and corner.
8. Vibration	4 cycles of 20 to 2000 Hz sinusoidal sweep with 20G peak acceleration lasting 12 minutes in X, Y, and Z directions.
9. Mechanical Shock	5 pulses of 10000g in each of the $\pm X$, $\pm Y$, and $\pm Z$ directions.
10. Electrostatic Discharge Test	Capacitance: 150pF Resistance: 330Ω Duration: 10 times Air Discharge: Level 4 ($\pm 15\text{kV}$) Direct contact discharge: Level 4 ($\pm 8\text{kV}$)
11. Human Body Mode	± 2000 Volt
12. Charged-Device Model	± 250 Volt
13. Reflow	5 reflow cycles with peak temperature of 260°C
14. Solderability	$245\pm 5^\circ\text{C}$, 5sec, 95% Tin on pad surface
15. Tumble test	300 tumbles from a height of 1m onto a steel base.



16. HAST	Temperature: 130±3°C Humidity: 85±3%RH Duration: 96 hours Voltage: Applied
17. Air Blow	0.45MPa, distance: 3cm, time: 10s

OUTLINE DIMENSIONS

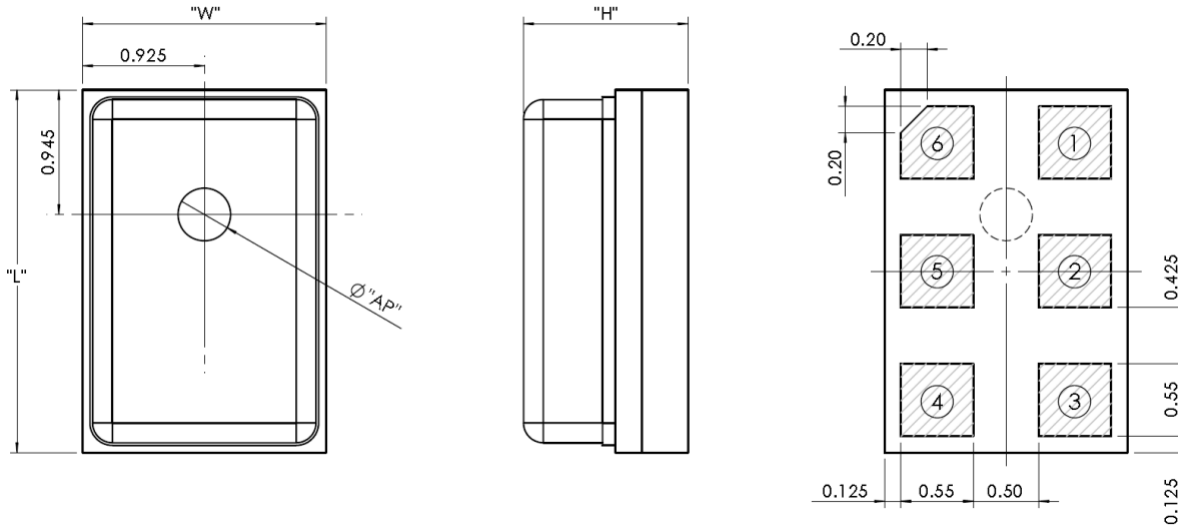


Figure 7. Outline Dimensions

Symbol	Dimensions		Tolerance	
	mm	inch	mm	inch
Length (L)	2.75	0.108	±0.100	±0.0039
Width (W)	1.85	0.073	±0.100	±0.0039
Height (H)	1.00	0.039	±0.100	±0.0039
Acoustic Port (AP)	Ø 0.40	Ø 0.016	±0.050	±0.0019



RECOMMENDED CUSTOMER LAND PATTERN

The recommended PCB land pattern for the AT6538 should have a 1:1 ratio to the solder pads on the microphone package. Care should be taken to avoid applying solder paste to the sound hole in PCB. The dimensions of suggested solder paste pattern refer to the land pattern which should be shrunk by 0.025 per side.

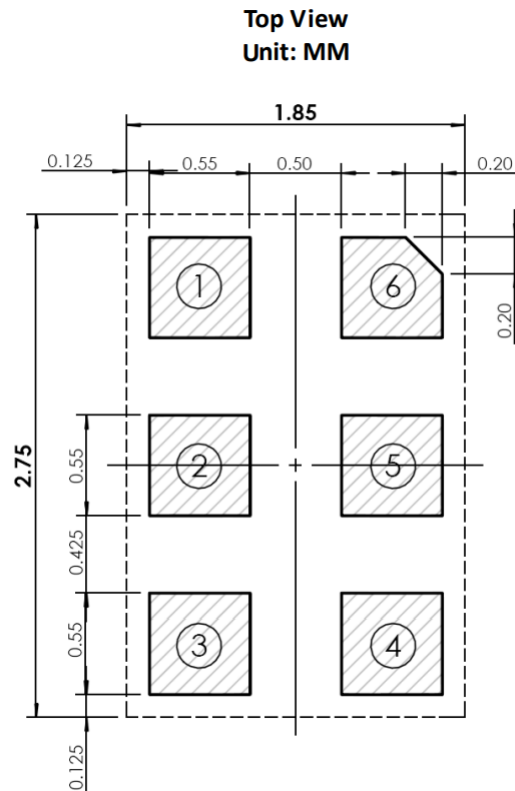
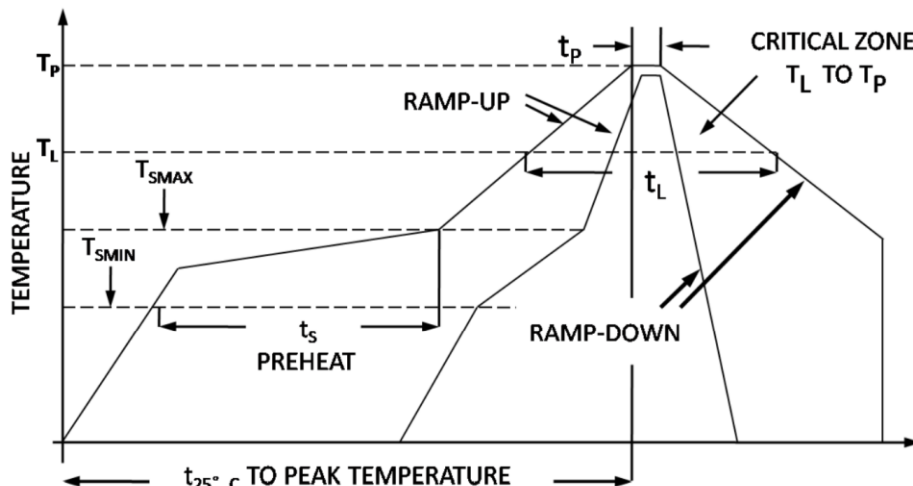


Figure 8. Recommended Land Pattern

SOLDER FLOW PROFILE

The reflow profile specified in this section describes expected maximum heat exposure of components during the reflow process of NMP product PWBs. Temperature is measured on top of component. All components have to tolerate at least this profile five times (5x) without affecting electrical performance, mechanical performance or reliability.







Pb-free and Sn63/Pb37 reflow profile requirements for soldering heat resistance:

Parameter		Reference	Pb-Free
Average Ramp Rate		T _L to T _P	1.25°C/sec max
Preheat	Minimum Temperature	T _{SMIN}	100°C
	Maximum Temperature	T _{SMAX}	200°C
	Time	T _{SMIN} to T _{SMAX}	60sec to 120sec
Time Maintained Above	Temperature	T _L	217°C
	Time	t _L	60sec to 150sec
Peak Temperature		T _P	260°C
Time within +5°C of Actual Peak Temperature		t _P	20 sec to 30 sec
Ramp-Down Rate		T _{peak}	6°C/sec max
Time +25°C (t _{25°C}) to Peak Temperature			8 min max

ORDERING INFORMATION

Part Number	Buy Now
AT6538	 *  *

NOTICE

- It is important to carefully read and follow the warnings, cautions, and product-specific notes provided with electronic components. These instructions are designed to ensure the safe and proper use of the component and to prevent damage to the component or surrounding equipment. Failure to follow these instructions could result in malfunction or failure of the component, damage to surrounding equipment, or even injury or harm to individuals. Always take the necessary precautions and seek professional assistance if unsure about proper use or handling of electronic components.
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